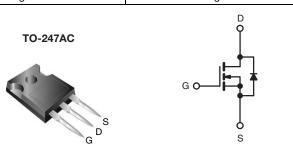


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Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	50	500				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.15				
Q _g (Max.) (nC)	210	210				
Q _{gs} (nC)	58	58				
Q _{gd} (nC)	10	100				
Configuration	Sing	Single				



N-Channel MOSFET

FEATURES

• Super Fast Body Diode Eliminates the Need for External Diodes in ZVS Applications



• Lower Gate Charge Results in Simpler Drive RoHS Requirements

- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP31N50LPbF		
Lead (FD)-life	SiHFP31N50L-E3		
SnPb	IRFP31N50L		
SIFD	SiHFP31N50L		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	7 °	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		31		
Continuous Drain Current	VGS at 10 V	T _C = 100 °C	I _D	20	A	
Pulsed Drain Current ^a			I _{DM}	124		
Linear Derating Factor				3.7	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	460	mJ	
Repetitive Avalanche Current ^a			I _{AR}	31	Α	
Repetitive Avalanche Energy ^a			E _{AR}	46	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	460	W	
Peak Diode Recovery dV/dt ^c			dV/dt	19	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d	7	
Mounting Toyour	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 1 mH, R_g = 25 Ω , I_{AS} = 31 A (see fig. 12).
- c. $I_{SD} \leq 31$ A, $dI/dt \leq 422$ A/µs, $V_{DD} \leq V_{DS},\, T_{J} \leq 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP31N50L, SiHFP31N50L

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.26		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.28	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V	-	-	± 100	nA
Zana Oata Wallana Barin Oamad		V _{DS} =	500 V, V _{GS} = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V	, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 19 A ^b	-	0.15	0.18	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 19 A ^b	15	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	5000	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 V,$	-	553	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5	-	59	-	
Outrat Conscitence	0		V _{DS} = 1.0 V , f = 1.0 MHz	-	6630	-	pF
Output Capacitance	C_{oss}	.,	V _{DS} = 400 V , f = 1.0 MHz	-	155	-	
Effective Output Capacitance	C _{oss} eff.	$V_{GS} = 0 V$)/ 0)// 400\/C	-	276	-	
Effective Output Capacitance	Coss eff. (ER)	1	$V_{DS} = 0 \text{ V to } 400 \text{ V}^{c}$	-	200	-	
Total Gate Charge	Qg			-	-	210	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 31 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 7 and 13 ^b		-	-	58	nC
Gate-Drain Charge	Q _{gd}	1	see lig. 7 and 10	-	-	100	1
Internal Gate Resistance	R _g	f = 1 MHz, open drain		-	1.1	-	Ω
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 250 \text{ V, } I_D = 31 \text{ A,}$ $R_g = 4.3 \ \Omega, \text{ see fig. } 10^b$		-	28	-	ns
Rise Time	t _r			-	115	-	
Turn-Off Delay Time	t _{d(off)}			-	54	-	
Fall Time	t _f			-	53	-	
Drain-Source Body Diode Characteristic	s				I.	•	<u> </u>
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	31	^
Pulsed Diode Forward Current ^a	I _{SM}			-	-	124	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 31 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 31 A		-	170	250	
		T _J = 125 °C, dl/dt = 100 A/μs ^b		-	220	330	ns
	0	T _J = 25 °C, I _S = 31 A, V _{GS} = 0 V ^b		-	570	860	nC
Body Diode Reverse Recovery Charge	Q_{rr}	T _J = 125 °C, dl/dt = 100 A/μs ^b		-	1.2	1.8	μC
Reverse Recovery Current	I _{RRM}	T _J = 25 °C		-	7.9	12	A
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%$. Coss eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} . C_{oss} eff. (ER) is a fixed capacitance that stores the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

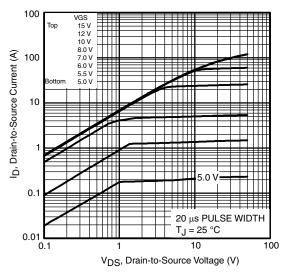


Fig. 1 - Typical Output Characteristics

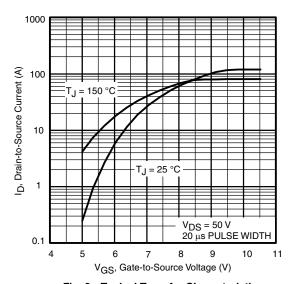


Fig. 3 - Typical Transfer Characteristics

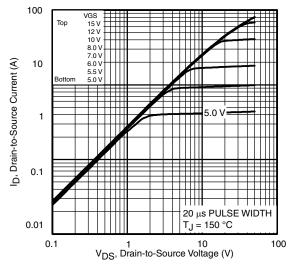


Fig. 2 - Typical Output Characteristics

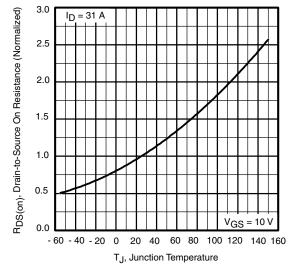


Fig. 4 - Normalized On-Resistance vs. Temperature

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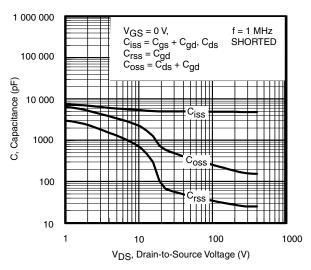


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

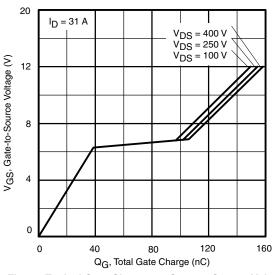


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

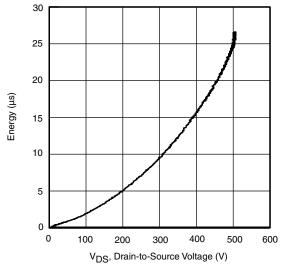


Fig. 6 - Output Capacitance Stored Energy vs. V_{DS}

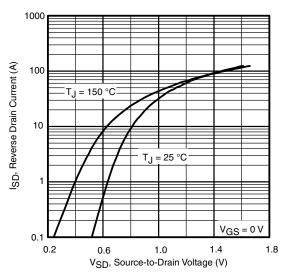


Fig. 8 - Typical Source Drain Diode Forward Voltage



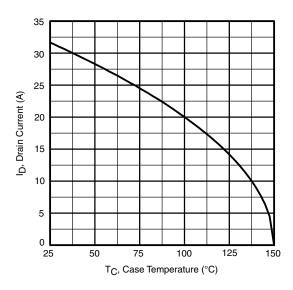


Fig. 9 - Maximum Drain Current vs. Case Temperature

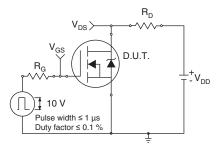


Fig. 10a - Switching Time Test Circuit

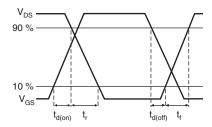


Fig. 10b - Switching Time Waveforms

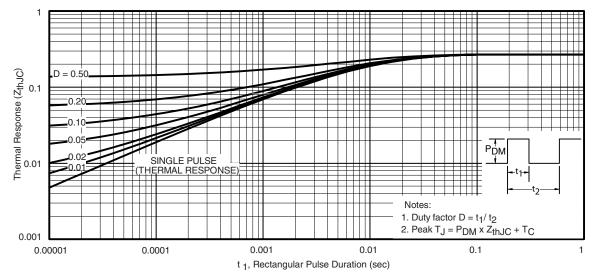


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

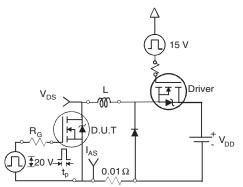


Fig. 12a - Unclamped Inductive Test Circuit

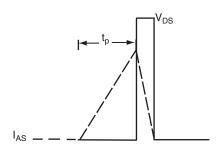


Fig. 12b - Unclamped Inductive Waveforms

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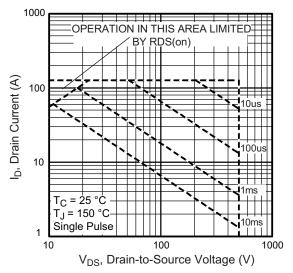
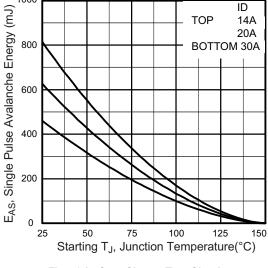


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



1000

Fig. 12d - Gate Charge Test Circuit

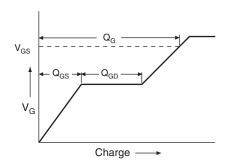


Fig. 13a - Maximum Safe Operating Area

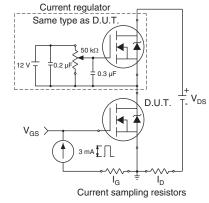
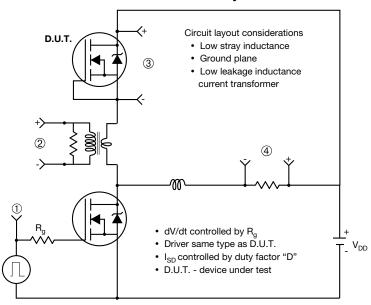


Fig. 13b - Basic Gate Charge Waveform



Peak Diode Recovery dV/dt Test Circuit



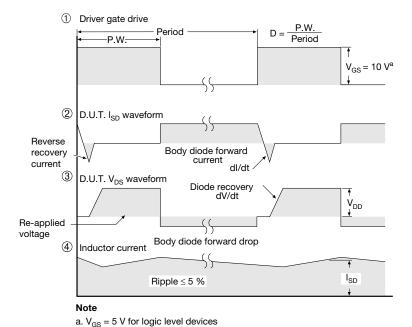


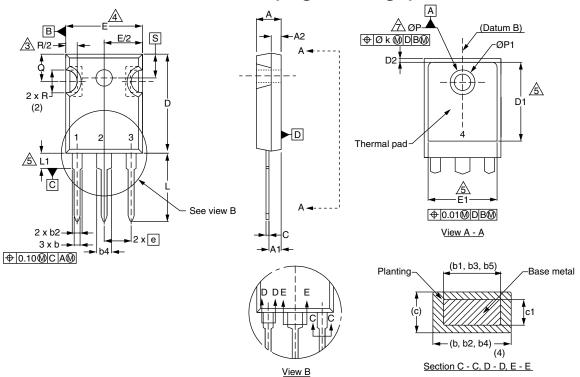
Fig. 14 - For N-Channel

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www.vishay.com

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TO-247AC (High Voltage)



	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D2	0.51	1.30	0.020	0.051
E	15.29	15.87	0.602	0.625
E1	13.72	-	0.540	-
е	5.46	BSC	0.215 BSC	
Øk	0.2	254	0.010	
L	14.20	16.25	0.559	0.640
L1	3.71	4.29	0.146	0.169
N	7.62 BSC		0.300	BSC
ØΡ	3.51	3.66	0.138	0.144
Ø P1	-	7.39	-	0.291
Q	5.31	5.69	0.209	0.224
R	4.52	5.49	0.178	0.216
S	5.51 BSC		0.217	BSC

ECN: X12-0167-Rev. B, 24-Sep-12

DWG: 5971

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
- 5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 24-Sep-12 1 Document Number: 91360



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